

SOT223 NPN SILICON PLANAR SWITCHING TRANSISTOR

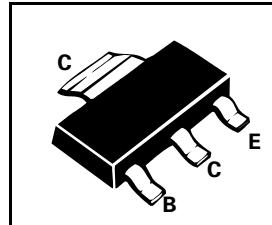
ISSUE 3 - OCTOBER 1995

FZT2222A

FEATURES

- * 40 Volt V_{CEO}
- * Fast switching

COMPLEMENTARY TYPE - FZT2907A
PARTMARKING DETAIL - FZT2222A



ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Collector-Base Voltage	V_{CBO}	75	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Continuous Collector Current	I_C	600	mA
Power Dissipation at $T_{amb}=25^\circ C$	P_{tot}	2	W
Operating and Storage Temperature Range	$T_j; T_{stg}$	-55 to +150	°C

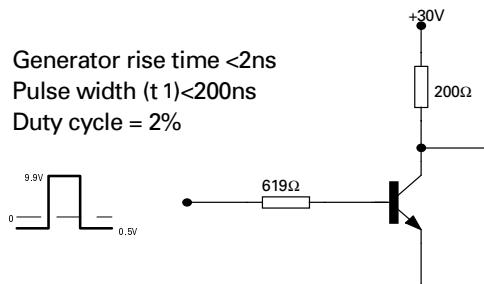
ELECTRICAL CHARACTERISTICS (at $T_{amb}=25^\circ C$ unless otherwise stated).

PARAMETER	SYMBOL	VALUE		UNIT	CONDITIONS.
		MIN.	MAX.		
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	75		V	$I_C=10\mu A, I_E=0$
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	40		V	$I_C=10mA, I_B=0$ *
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	6		V	$I_E=10\mu A, I_C=0$
Collector Cut-Off Current	I_{CBO}		10 10	nA μA	$V_{CB}=50V, I_E=0$ $V_{CB}=50V, I_E=0, T_{amb}=150^\circ C$
Emitter Cut-Off Current	I_{EBO}		10	nA	$V_{EB}=3V, I_C=0$
Collector-Emitter Cut-Off Current	I_{CEX}		10	nA	$V_{CE}=60V, V_{EB(off)}=3V$
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$		0.3 1.0	V V	$I_C=150mA, I_B=15mA$ * $I_C=500mA, I_B=50mA$ *
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	0.6	1.2 2.0	V V	$I_C=150mA, I_B=15mA$ * $I_C=500mA, I_B=50mA$ *
Static Forward Current Transfer Ratio	h_{FE}	35 50 75 35 100 50 40	300		$I_C=0.1mA, V_{CE}=10V$ * $I_C=1mA, V_{CE}=10V$ * $I_C=10mA, V_{CE}=10V$ * $I_C=10mA, V_{CE}=10V, T_{amb}=-55^\circ C$ * $I_C=150mA, V_{CE}=10V$ * $I_C=150mA, V_{CE}=1V$ * $I_C=500mA, V_{CE}=10V$ *

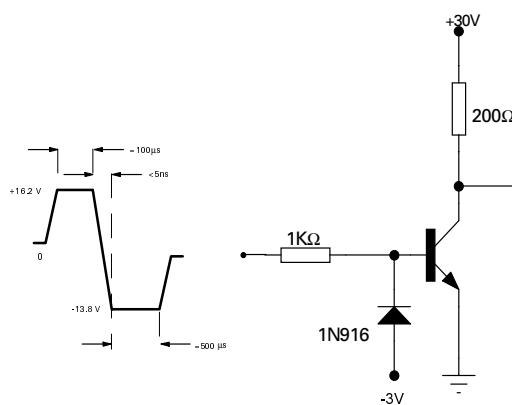
*Measured under pulsed conditions. Pulse width=300μs. Duty cycle ≤ 2%
Spice parameter data is available upon request for this device

ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^\circ C$ unless otherwise stated).

PARAMETER	SYMBOL	VALUE		UNIT	CONDITIONS.
		MIN.	MAX.		
Transition Frequency	f_T	300		MHz	$I_C=20mA$, $V_{CE}=20V$ $f=100MHz$
Output Capacitance	C_{obo}		8	pF	$V_{CB}=10V$, $I_E=0$, $f=140KHz$
Input Capacitance	C_{ibo}		25	pF	$V_{EB}=0.5V$, $I_C=0$ $f=140KHz$
Delay Time	t_d		10	ns	$V_{CE}=30V$, $V_{BE(off)}=0.5V$
Rise Time	t_r		25	ns	$I_C=150mA$, $I_{B1}=15mA$ (See Delay Test Circuit)
Storage Time	t_s		225	ns	$V_{CE}=30V$, $I_C=150mA$
Fall Time	t_f		60	ns	$I_{B1}=I_{B2}=15mA$ (See Storage Test Circuit)

DELAY AND RISE – TEST CIRCUIT


Scope:
 $R_{in} > 100 k\Omega$
 $C_{in} < 12 pF$
Rise Time < 5 ns

STORAGE TIME AND FALL TIME – TEST CIRCUIT


Scope:
 $R_{in} > 100 k\Omega$
 $C_{in} < 12 pF$
Rise Time < 5 ns

Duty cycle = 2%